

What is Claimed is:

- 1 1. A phase-locked loop, comprising:
 - 2 a divider for receiving a reference clock with a substantially fixed period and
 - 3 generating an output clock with a time-varying period;
 - 4 a noise-shaped quantizer for quantizing a period control word to a time-varying
 - 5 value in response to said output clock fed from said divider so that said divider
 - 6 generates said output clock by means of dividing said reference clock by said
 - 7 time-varying value;
 - 8 a filter for substantially filtering out jitter from said output clock;
 - 9 a phase detector for generating a phase error in response to said filtered output
 - 10 clock and an input signal; and
 - 11 a digital loop filter for generating said period control word in response to said
 - 12 phase error.
- 1 2. The phase-locked loop as claimed in claim 1, wherein said period control word
- 2 has a bit resolution greater than that of said time-varying value.
- 1 3. The phase-locked loop as claimed in claim 1, wherein said noise-shaped
- 2 quantizer is a delta-sigma quantizer.
- 1 4. The phase-locked loop as claimed in claim 1, wherein said filter is an analog
- 2 phase locked loop (PLL) device as a low pass filter for removing high frequency jitter
- 3 from said output clock.
- 1 5. The phase-locked loop as claimed in claim 1, further comprising a phase

2 shifter for shifting a phase of said filtered output clock.

1 6. The phase-locked loop as claimed in claim 1, further comprising another
2 divider for dividing said filtered output clock by a divisor such that said phase
3 detector generates said phase error in response to said divided output clock and said
4 input signal.

1 7. A phase-locked loop, comprising:

2 a first divider for receiving a reference clock with a substantially fixed period
3 and generating an output clock with a time-varying period;
4 a noise-shaped quantizer for quantizing a period control word to a time-varying
5 value in response to said output clock fed from said first divider so that said first
6 divider generates said output clock by means of dividing said reference clock by said
7 time-varying value;
8 a filter for substantially filtering out jitter from said output clock;
9 a second divider for dividing said filtered output clock by said period control
10 word so as to generate one divided output clock;
11 a phase detector for generating a phase error in response to said divided output
12 clock and an input signal; and
13 a digital loop filter for generating said period control word in response to said
14 phase error.

1 8. The phase-locked loop as claimed in claim 7, wherein said period control word
2 has a bit resolution greater than that of said time-varying value.

1 9. The phase-locked loop as claimed in claim 7, wherein said noise-shaped

2 quantizer is a delta-sigma quantizer.

1 10. The phase-locked loop as claimed in claim 7, wherein said filter is an analog
2 phase locked loop (PLL) device as a low pass filter for removing high frequency jitter
3 from said output clock.

1 11. The phase-locked loop as claimed in claim 7, further comprising a phase
2 shifter for shifting a phase of said filtered output clock.

1 12. The phase-locked loop as claimed in claim 7, further comprising a third
2 divider for dividing said one divided output clock by a divisor to another divided
3 output clock such that said phase detector generates said phase error in response to
4 said another divided output clock and said input signal.